

Notice of References Cited	Application/Control No. 10/749,650	Applicant(s)/Patent Under Reexamination PARK, TAE-HEE	
	Examiner Granvill D. Lee Jr	Art Unit 2891	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2002/0072016	06-2002	Chen et al.	430/323
	C	US-2001/0051439	12-2001	Khan et al.	438/710
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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